

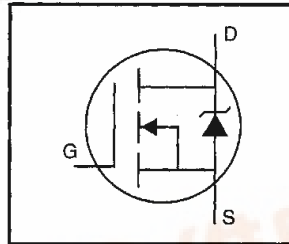
International IR Rectifier

PD - 95366

IRF710PbF

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

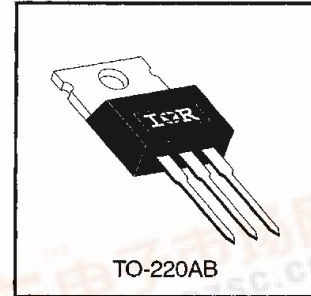


$V_{DSS} = 400V$
 $R_{DS(on)} = 3.6\Omega$
 $I_D = 2.0A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



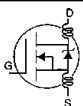
Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 2.0 | A |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 1.2 | |
| I_{DM} | Pulsed Drain Current ① | 6.0 | |
| $P_D @ T_C = 25^\circ C$ | Power Dissipation | 36 | W |
| | Linear Derating Factor | 0.29 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E_{AS} | Single Pulse Avalanche Energy ② | 120 | mJ |
| I_{AR} | Avalanche Current ① | 2.0 | A |
| E_{AR} | Repetitive Avalanche Energy ① | 3.6 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 4.0 | V/ns |
| T_J T_{STG} | Operating Junction and Storage Temperature Range | -55 to +150 | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1 N•m) | |

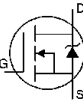
Thermal Resistance

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | — | 3.5 | °C/W |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | — | 0.50 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient | — | — | 62 | |

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

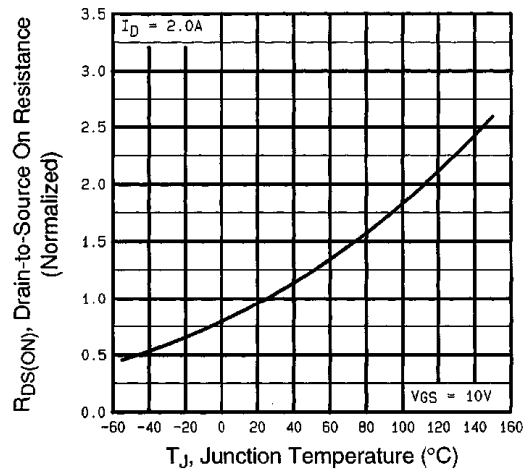
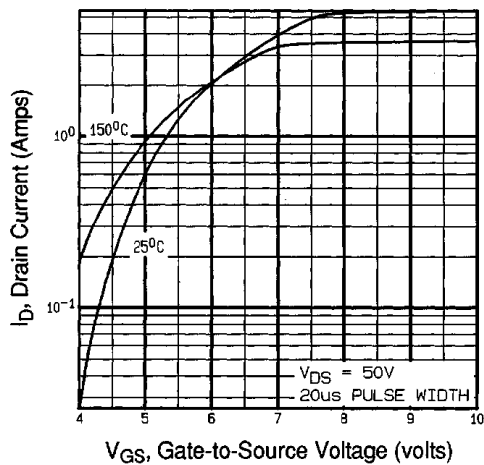
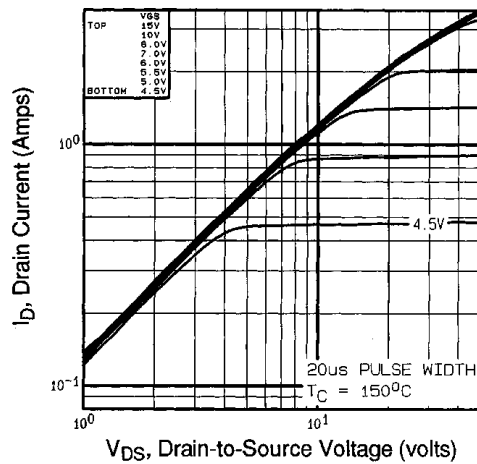
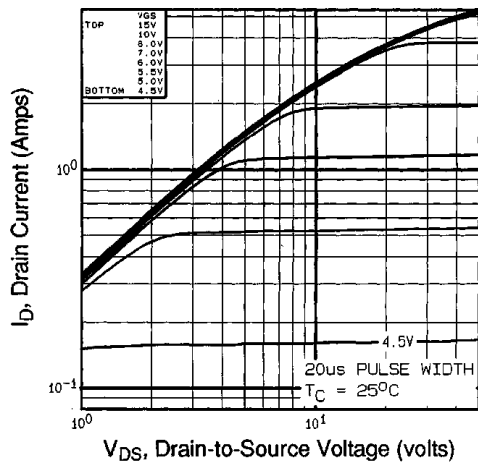
| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|--|--------------------------------------|------|------|------|-------|---|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 400 | — | — | V | V _{GS} =0V, I _D = 250μA |
| ΔV _{(BR)DSS} /ΔT _J | Breakdown Voltage Temp. Coefficient | — | 0.47 | — | V/°C | Reference to 25°C, I _D = 1mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | — | — | 3.6 | Ω | V _{GS} =10V, I _D =1.2A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | — | 4.0 | V | V _{DS} =V _{GS} , I _D = 250μA |
| g _{fs} | Forward Transconductance | 1.0 | — | — | S | V _{DS} =50V, I _D =1.2A ④ |
| I _{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | V _{DS} =400V, V _{GS} =0V |
| | | — | — | 250 | | V _{DS} =320V, V _{GS} =0V, T _J =125°C |
| I _{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | V _{GS} =20V |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | V _{GS} =-20V |
| Q _g | Total Gate Charge | — | — | 17 | nC | I _D =2.0A |
| Q _{gs} | Gate-to-Source Charge | — | — | 3.4 | | V _{DS} =320V |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | — | — | 8.5 | | V _{GS} =10V See Fig. 6 and 13 ④ |
| t _{d(on)} | Turn-On Delay Time | — | 8.0 | — | ns | V _{DD} =200V |
| t _r | Rise Time | — | 9.9 | — | | I _D =2.0A |
| t _{d(off)} | Turn-Off Delay Time | — | 21 | — | | R _G =24Ω |
| t _f | Fall Time | — | 11 | — | | R _D =95Ω See Figure 10 ④ |
| L _D | Internal Drain Inductance | — | 4.5 | — | nH | Between lead, 6 mm (0.25in.) from package and center of die contact |
| L _S | Internal Source Inductance | — | 7.5 | — | |  |
| C _{iss} | Input Capacitance | — | 170 | — | pF | V _{GS} =0V |
| C _{oss} | Output Capacitance | — | 34 | — | | V _{DS} =25V |
| C _{rss} | Reverse Transfer Capacitance | — | 6.3 | — | | f=1.0MHz See Figure 5 |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|-----------------|--|--|------|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | — | — | 2.0 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I _{SM} | Pulsed Source Current (Body Diode) ① | — | — | 6.0 | | |
| V _{SD} | Diode Forward Voltage | — | — | 1.6 | V | T _J =25°C, I _S =2.0A, V _{GS} =0V ④ |
| t _{rr} | Reverse Recovery Time | — | 240 | 540 | ns | T _J =25°C, I _F =2.0A |
| Q _{rr} | Reverse Recovery Charge | — | 0.85 | 1.6 | μC | di/dt=100A/μs ④ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ② V_{DD}=50V, starting T_J=25°C, L=52mH
R_G=25Ω, I_{AS}=2.0A (See Figure 12)
- ③ I_{SD}≤2.0A, di/dt≤40A/μs, V_{DD}≤V_{(BR)DSS},
T_J≤150°C
- ④ Pulse width ≤ 300 μs; duty cycle ≤2%.



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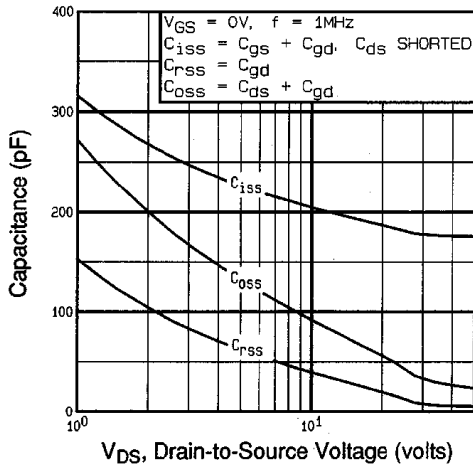


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

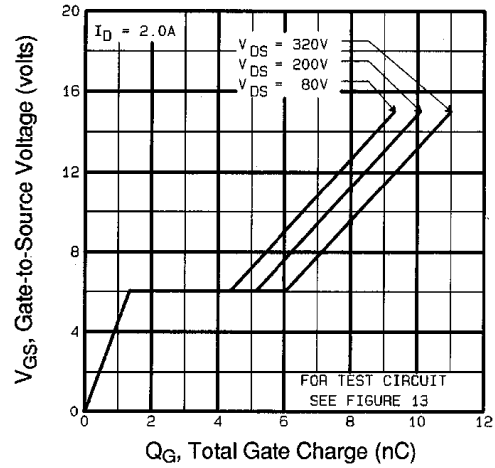


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

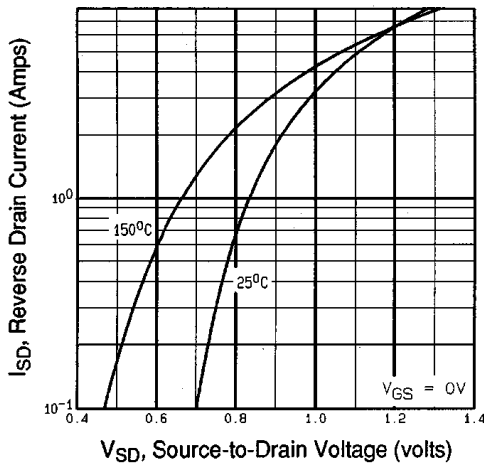


Fig 7. Typical Source-Drain Diode Forward Voltage

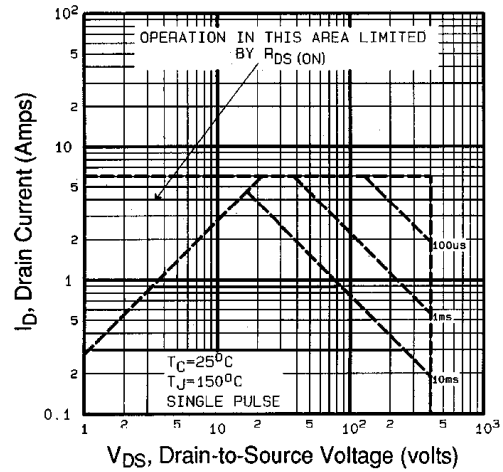


Fig 8. Maximum Safe Operating Area

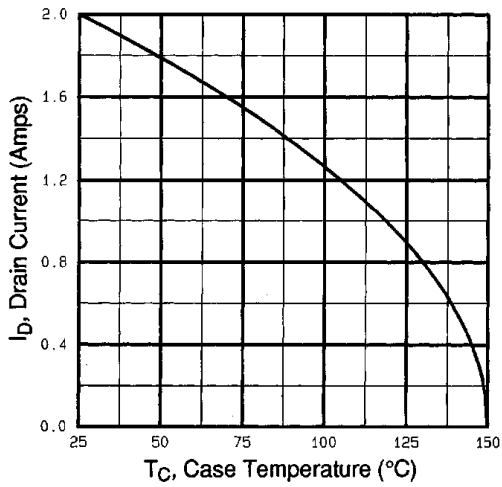


Fig 9. Maximum Drain Current Vs. Case Temperature

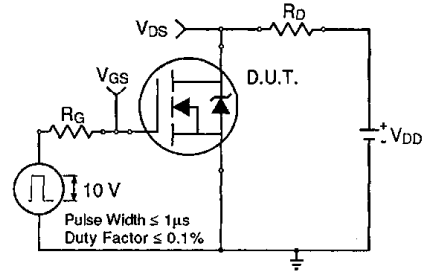


Fig 10a. Switching Time Test Circuit

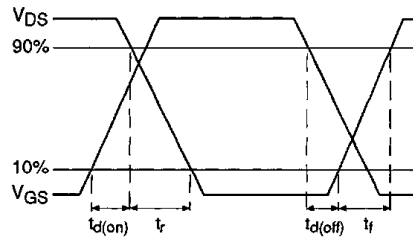


Fig 10b. Switching Time Waveforms

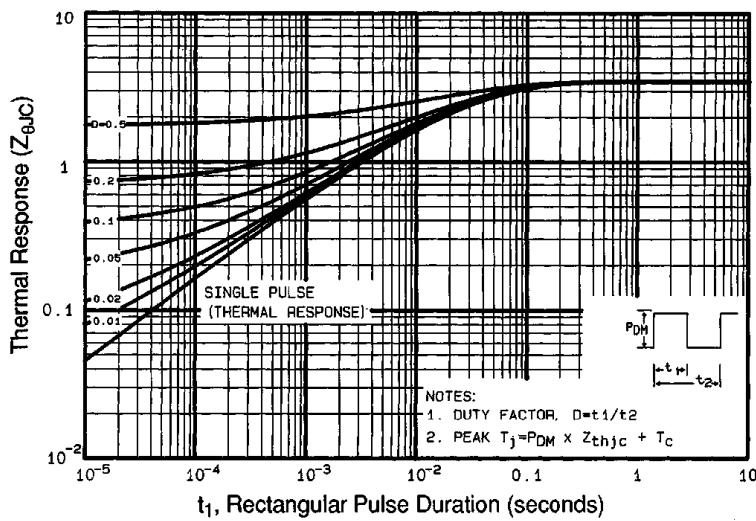


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRF710PbF

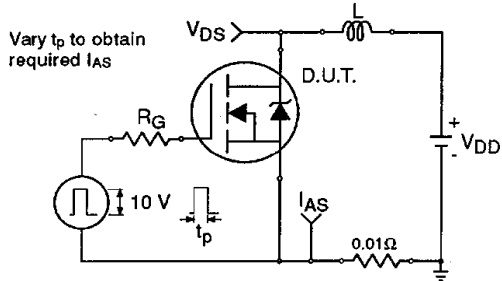


Fig 12a. Unclamped Inductive Test Circuit

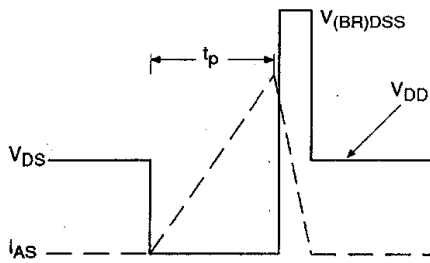


Fig 12b. Unclamped Inductive Waveforms

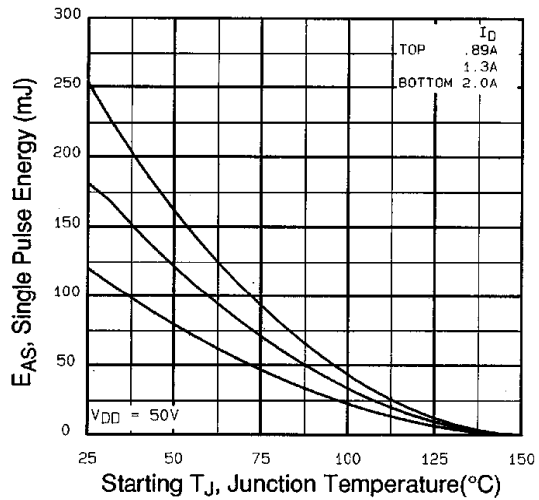


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

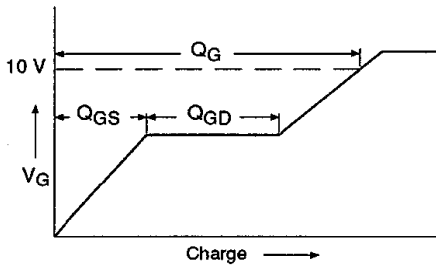


Fig 13a. Basic Gate Charge Waveform

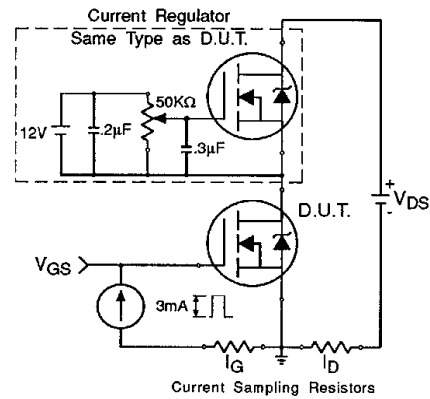
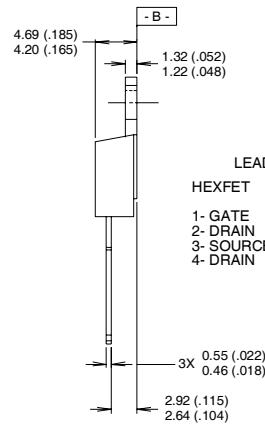
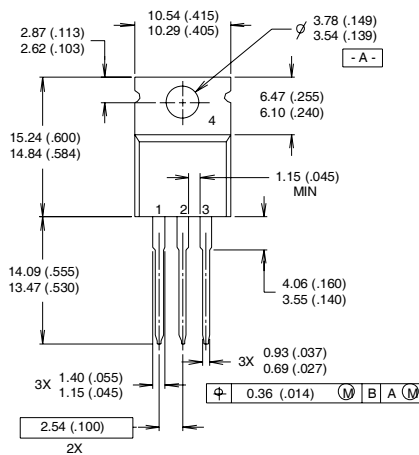


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit – See page 1505

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



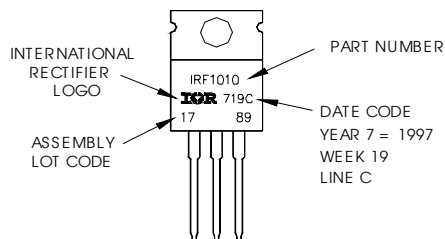
LEAD ASSIGNMENTS

| HEXFET | IGBTs, CoPACK |
|-----------|---------------|
| 1- GATE | 1- GATE |
| 2- DRAIN | 2- COLLECTOR |
| 3- SOURCE | 3- EMITTER |
| 4- DRAIN | 4- COLLECTOR |

- NOTES:
- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
 - 2 CONTROLLING DIMENSION : INCH
 - 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
 - 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"
Note: "P" in assembly line
 position indicates "Lead-Free"



Data and specifications subject to change without notice.